

# **RDEN-048050**

## **RELIABILITY DATA**

DWG. No. SC-575-RDEN-048050-001			
QA	Engineering		
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The following data are typical values. As all units have nearly the same characteristics, the data to be considered as ability values.

## 1. Calculated Values of MTBF

MODEL : RDEN-048050

## (1) Calculating Method

Calculated based on parts stress reliability projection of MIL-HDBK-217F NOTICE2.

Individual failure rates  $\lambda_G$  is given to each part and MTBF is calculated by the count of each part.

$$MTBF = \frac{1}{\lambda_{equip}} = \frac{1}{\sum_{i=1}^n N_i (\lambda_G \pi_Q)_i} \times 10^6 \text{ (hours)}$$

$\lambda_{equip}$  : Total equipment failure rate (Failure /  $10^6$  Hours)

$\lambda_G$  : Generic failure rate for the  $i$ th generic part (Failure/  $10^6$  Hours)

$N_i$  : Quantity of  $i$ th generic part

$N$  : Number of different generic part categories

$\pi_Q$  : Generic quality factor for the  $i$ th generic part ( $\pi_Q=1$ )

## (2) MTBF Values

$G_F$  : Ground, Fixed

$$\underline{MTBF = 11,598,237 \text{ (Hours)}}$$

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## 2. Vibration Test

MODEL: RDEN-048050

## (1) Vibration Test Class

Frequency Variable Endurance Test

## (2) Equipment Used

Controller VS-1000-6, Vibrator 905-FN (IMV CORP.)

## (3) The Number of D.U.T. (Device Under Test)

5 units

## (4) Test Condition

Frequency : 10~55Hz

Amplitude : 1.5mm, Sweep for 1 min.

Dimension and times : X,Y and Z directions for 2 hours each.

## (5) The Method

Fix the D.U.T. on the fitting-stage

## (6) Test Results

PASS

## Typical Sample Data

Check item	Spec.	Before Test	After Test	
Attenuation(dB)	Differential Mode : 25dB min.	0.2 MHz	29.62	30.00
		20 MHz	49.94	52.90
	Common Mode: 30dB min.	0.7 MHz	72.56	70.47
		30 MHz	35.93	35.41
DC Resistance (Ω)	3 Ω max.	1.98	2.03	
Test Voltage	L-L : 100Vdc 60sec. L-E : 1500Vdc 60sec.	OK	OK	
Isolation Resistance(MΩ)	500 MΩ min.(500Vdc 60sec.)	1.73 x 10 <sup>6</sup>	2.12 x 10 <sup>6</sup>	

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3. Heat Cycle Test

MODEL: RDEN-048050

(1)Equipment Used

TEMPERATURE CHAMBER TSA-71H-W (ESPEC CORP.)

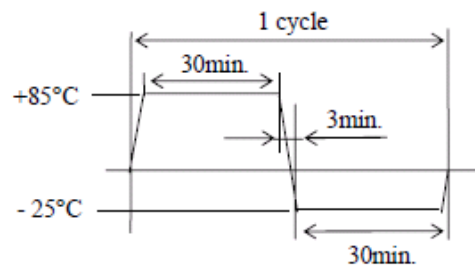
(2)The Number of D.U.T. (Device Under Test)

5 units

(3)Test Conditions

Ambient Temperature : -25~+85°C

Test Cycles: 100 cycles



(4)The Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above cycles, After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5)Test Results

PASS

Typical Sample Data

Check item	Spec.	Before Test	After Test	
Attenuation(dB)	Differential Mode : 25dB min.	0.2 MHz	29.46	29.50
		20 MHz	47.89	50.70
	Common Mode: 30dB min.	0.7 MHz	71.00	69.28
		30 MHz	35.29	36.51
DC Resistance (Ω)	3 Ω max.	1.97	1.97	
Test Voltage	L-L : 100Vdc 60sec. L-E : 1500Vdc 60sec.	OK	OK	
Isolation Resistance(MΩ)	500 MΩ min.(500Vdc 60sec.)	1.73 x 10 <sup>6</sup>	2.10 x 10 <sup>6</sup>	

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## 4. Humidity Test

MODEL: RDEN-048050

## (1)Equipment Used

TEMP. &amp; HUMID. CHAMBER PR-4KT (ESPEC CORP.)

## (2)The Number of D.U.T. (Device Under Test)

5 units

## (3)Test Conditions

Ambient Temperature : +40°C

Test Times: 500 hours

Ambient Humidity: 90~95%RH No Dewdrop

## (4)The Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions.

After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

## (5)Test Results

PASS

## Typical Sample Data

Check item	Spec.	Before Test	After Test	
Attenuation(dB)	Differential Mode : 25dB min.	0.2 MHz	29.56	29.98
		20 MHz	49.03	52.27
	Common Mode: 30dB min.	0.7 MHz	73.04	70.07
		30 MHz	35.40	35.28
DC Resistance (Ω)	3 Ω max.	1.95	1.84	
Test Voltage	L-L : 100Vdc 60sec. L-E : 1500Vdc 60sec.	OK	OK	
Isolation Resistance(MΩ)	500 MΩ min.(500Vdc 60sec.)	1.65 x 10 <sup>6</sup>	1.74 x 10 <sup>6</sup>	

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5. High Temperature Resistance Test

MODEL: RDEN-048050

(1)Equipment Used

TEMPERATURE CHAMBER PHH-300 (ESPEC CORP.)

(2)The Number of D.U.T. (Device Under Test)

5 units

(3)Test Conditions

Ambient Temperature : +55°C

Test Times: 500 hours

Operating: DC 50A

(4)The Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions.

After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5)Test Results

PASS

Typical Sample Data

Check item	Spec.	Before Test	After Test	
Attenuation(dB)	Differential Mode : 25dB min.	0.2 MHz	29.43	29.47
		20 MHz	49.84	53.77
	Common Mode: 30dB min.	0.7 MHz	69.55	67.74
		30 MHz	35.35	35.84
DC Resistance (Ω)	3 Ω max.	1.95	1.97	
Test Voltage	L-L : 100Vdc 60sec. L-E : 1500Vdc 60sec.	OK	OK	
Isolation Resistance(MΩ)	500 MΩ min.(500Vdc 60sec.)	1.61 x 10 <sup>6</sup>	1.84 x 10 <sup>6</sup>	

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## 6. Low Temperature Storage Test

MODEL: RDEN-048050

## (1)Equipment Used

TEMPERATURE CHAMBER PG-2FT (ESPEC CORP.)

## (2)The Number of D.U.T. (Device Under Test)

5 units

## (3)Test Conditions

Ambient Temperature : -25°C

Test Times: 500 hours

## (4)The Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

## (5)Test Results

PASS

## Typical Sample Data

Check item	Spec.		Before Test	After Test
Attenuation(dB)	Differential Mode : 25dB min.	0.2 MHz	29.53	29.58
		20 MHz	48.56	51.87
	Common Mode: 30dB min.	0.7 MHz	68.66	70.13
		30 MHz	34.36	34.28
DC Resistance (Ω)	3 Ω max.		1.97	2.03
Test Voltage	L-L : 100Vdc 60sec. L-E : 1500Vdc 60sec.		OK	OK
Isolation Resistance(MΩ)	500 MΩ min.(500Vdc 60sec.)		1.71 x 10 <sup>6</sup>	1.62 x 10 <sup>6</sup>